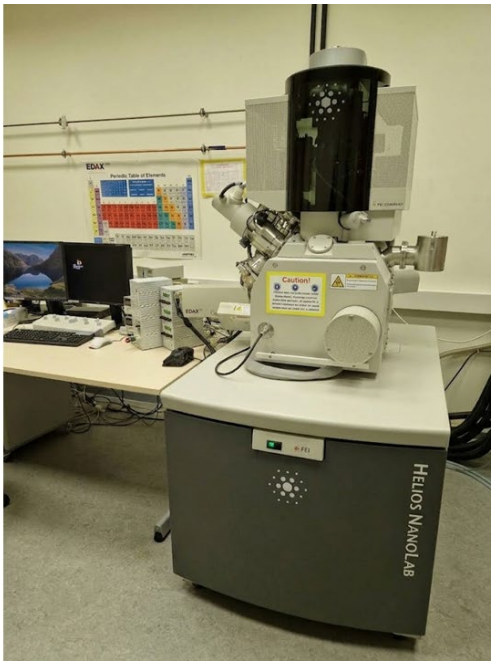
Universität Siegen / Naturwissenschaftlich-Technische Fakultät

Available: FEI Helios Nanolab 600 DualBeam FIB/SEM





System Configuration:

Electron source:	FEG
Ion Source:	Ga
Manipulator:	Kleindiek Manipulator MM3A (1)
GIS:	Platinum (PT10)
Detectors:	ETD, TLD, VCD, STEM II, CDEM
Analytical:	Ametek EDAX (3D EBSD-G2)
Software:	Slice-and-View G2; Nanobuilder
Lithography:	Raith Nanobuilder EBL with fast beam blanker

Status and Terms:

Status:	System under low vacuum
Terms:	Sold as-is/where-is

Tool is sold as-is. The turbo pump controller needs repair so the tool can be visually inspected, but the chamber is only under low vacuum.

Offers invited by 15 November 2026
For details, including serial numbers, please inquire

Contact: Eric Woods, eric.woods@uni-siegen.de